Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination	
10724843	BHANU ET AL.	
Examiner	Art Unit	
Liu, Lin	2145	

SEARCHED					
Class	Subclass	Date	Examiner		
709	250	06/21/2007	L.L		

SEARCH NOTES			
Search Notes	Date	Examiner	
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB,	06/21/2007	L.L	
see search history printout.			
L1: 709/250.ccls. and (@ad<20031201) reviewed consicely	06/21/2007	L.L	
709/250.ccls. not L1, reviewed cursory.	06/21/2007	L.L	
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB,	12/09/2007	L.L	
see search history printout.			

	INTERFERENCE SEA	ARCH	
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20071208